

**Search Notes**

Application/Control No.

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Examiner

Le Nguyen

Applicant(s)/Patent under  
Reexamination

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Art Unit

2174

**SEARCHED**

Class	Subclass	Date	Examiner
715	745	7/5/2006	LVN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
US-PGPUB, USPAT: 715/745		7/5/2006	LVN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
US-PGPUB, USPAT: 715/734,735,738,745-748,751,853; 706/6,15,20,45	7/5/2006	LVN